



## **AOD410**

### N-Channel Enhancement Mode Field Effect Transistor

## **General Description**

The AOD410 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications.

- -RoHS Compliant
- -Halogen Free\*

#### **Features**

 $V_{DS}(V) = 30V$ 

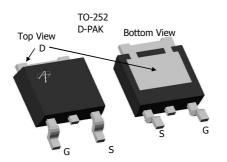
 $I_D = 8A (V_{GS} = 10V)$ 

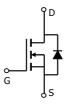
 $R_{DS(ON)}$  < 65m $\Omega$  ( $V_{GS}$  = 10V)

-55 to 175

 $R_{DS(ON)} < 105 m\Omega (V_{GS} = 4.5 V)$ 

100% UIS Tested! 100% Rg Tested!





Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted								
Parameter Drain-Source Voltage Gate-Source Voltage		Symbol	Maximum	Units V				
		V <sub>DS</sub>	30					
		$V_{GS}$	±20	V				
Continuous Drain	T <sub>C</sub> =25°C		8					
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	6	A				
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	20					
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	8	A				
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	10	mJ				
	T <sub>C</sub> =25°C	P <sub>D</sub>	25	W				
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C		12.5	VV				
	T <sub>A</sub> =25°C	Page	2.1	10/				
Power Dissipation A	T <sub>A</sub> =70°C	PDSM	1.33	W				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	R <sub>0JA</sub>	20	30	°C/W			
Maximum Junction-to-Ambient A	Steady-State	ГејД	46	60	°C/W			
Maximum Junction-to-Case <sup>C</sup> Steady-State		$R_{\theta JL}$	5.3	7	°C/W			

 $T_J, T_{STG}$ 

Junction and Storage Temperature Range

°C

#### Electrical Characteristics (T<sub>j</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		30			V
ı	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V				1	μА
I <sub>DSS</sub>			T <sub>J</sub> =55°C			5	μΑ
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1	1.8	3	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V		10			Α
R <sub>DS(ON)</sub>		$V_{GS}$ =10V, $I_D$ =8A			48	65	mΩ
	Static Drain-Source On-Resistance		T <sub>J</sub> =125°C		76	100	11152
		$V_{GS}$ =4.5V, $I_D$ =2A			75	105	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =8A			6.2		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.75	1	V
Is	Maximum Body-Diode Continuous Current					4.3	Α
DYNAMIC	PARAMETERS						,
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			288		pF
C <sub>oss</sub>	Output Capacitance				57		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				39		pF
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			3		Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	-V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =8A			6.72		nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				3.34		nC
$Q_{gs}$	Gate Source Charge				0.76		nC
$Q_{gd}$	Gate Drain Charge				1.78		nC
t <sub>D(on)</sub>	Turn-On DelayTime				3.7		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1.8 $\Omega$ , $R_{GEN}$ =3 $\Omega$			3.7		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				15.6		ns
t <sub>f</sub>	Turn-Off Fall Time				2.6		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8A, dI/dt=100A/μs			12.6		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =8A, dI/dt=100A/μs			5.1		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The Power dissipation  $P_{DSM}$  is based on R  $_{\theta JA}$  and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature for 175°C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =175°C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to case  $R_{\theta JC}$  and case to ambient.

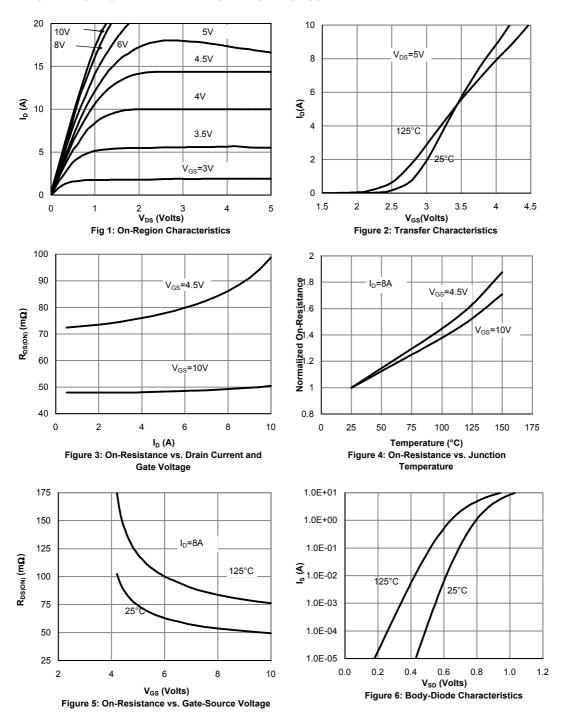
E. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu s$  pulses, duty cycle 0.5% max.

F. These tests are performed with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

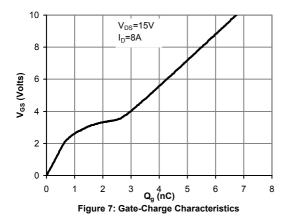
G. The maximum current rating is limited by bond-wires.

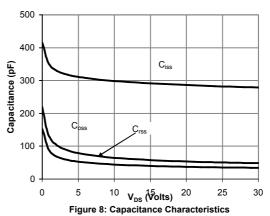
<sup>\*</sup>This device is guaranteed green after data code 8X11 (Sep 1<sup>ST</sup> 2008). Rev4: Oct 2008

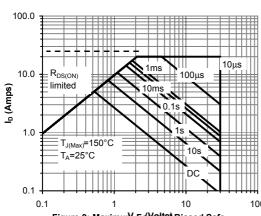
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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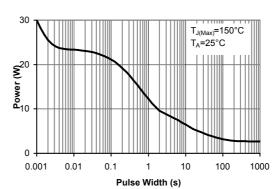
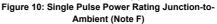


Figure 9: Maximun/u5d/Modife) Biased Safe Operating Area (Note F)



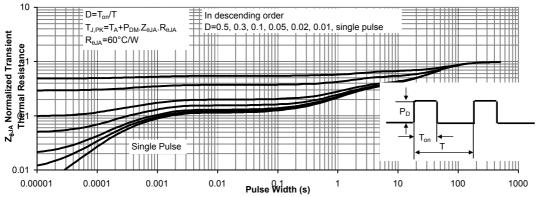
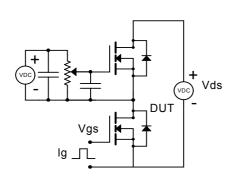
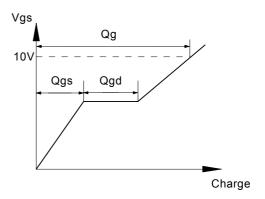


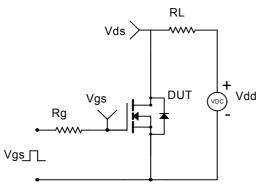
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

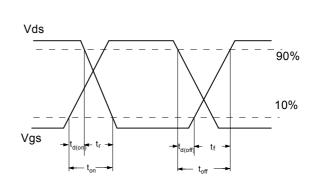
# Gate Charge Test Circuit & Waveform



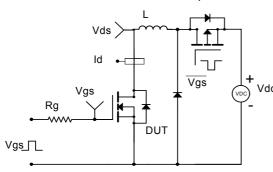


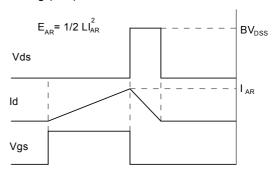
# Resistive Switching Test Circuit & Waveforms





## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

